

30V 5.6mohm N-channel enhancement MOSFET

AKT3080K

Description:

This N Channel Trench MOSFET has been designed to low on-state resistance ($R_{DS(on)}$), suggested use for battery protection, special for high efficiency power management applications.

Features:

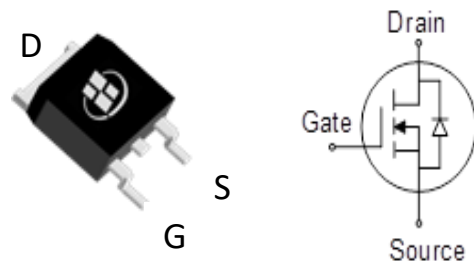
- Advanced Trench Technology
- Excellent Gate Charge $\times R_{DS(on)}$ (FOM)
- low on-resistance
- RoHS compliant ^(Note 1)
- Halogen-free ^(Note 1)

Applications:

- Battery Protection
- Load Switch
- Power Management

Key Performance Parameters:

Parameter	Value	Unit
V_{DS}	30	V
$R_{DS(on), max} @ V_{GS} = 10V$	5.6	m Ω
I_D	70	A



Ordering Information:

Ordering Code	Package Type	Marking Code	Form	Packing
AKT3080K	TO-252	AKT3080K	Tape Reel	See the detail package information

Notes:

1. Contact ALKAIDSEMI sales for detail information

Maximum Ratings $(T_A = 25^\circ\text{C}$ unless otherwise noted)

Symbol	Parameter	Value	Units
V_{DS}	Drain-Source Voltage	30	V
I_D	Drain Current - Continuous $(T_C = 25^\circ\text{C})$ ^(Note 1)	80	A
	Drain Current - Continuous $(T_C = 25^\circ\text{C})$ ^(Note 2)	70	A
	Drain Current - Continuous $(T_C = 100^\circ\text{C})$	45	A
I_{DM}	Drain Current - Pulsed ^(Note 3)	280	A
V_{GS}	Gate-Source Voltage	± 20	V
E_{AS}	Single Pulsed Avalanche Energy ^(Note 4)	100	mJ
P_D	Power Dissipation $(T_C = 25^\circ\text{C})$	57	W
T_J, T_{STG}	Operating and Storage Temperature Range	-55 to +150	$^\circ\text{C}$

Thermal Characteristics

Symbol	Parameter	Value	Units
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case, Steady-State	2.2	$^\circ\text{C/W}$
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient, Steady State ^(Note 5)	56	$^\circ\text{C/W}$

Notes:

1. The max drain current rating is silicon limited
2. The max drain current rating is package limited
3. Repetitive Rating: Pulse width limited by maximum junction temperature
4. $L = 0.5\text{ mH}$, $V_{DD} = 15\text{ V}$, $I_{AS} = 20\text{ A}$, $R_G = 25\ \Omega$, Starting $T_J = 25\ ^\circ\text{C}$
5. Mount on minimum PCB layout

Electrical Characteristics ($T_J = 25^\circ\text{C}$ unless otherwise noted)

Symbol	Parameter	Test Conditions	Min	Typ	Max	Units
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Static Characteristics

BV_{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0\text{ V}, I_D = 250\text{ }\mu\text{A}$	30			V
I_{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = 30\text{ V}, V_{GS} = 0\text{ V},$			1	μA
I_{GSS}	Gate Leakage Current	$V_{GS} = \pm 20\text{ V}, V_{DS} = 0\text{ V}$			± 100	nA
$V_{GS(TH)}$	Gate Threshold voltage	$V_{DS} = V_{GS}, I_D = 250\text{ }\mu\text{A}$	1	1.4	2	V
$R_{DS(ON)}$	Drain-Source on-state resistance	$V_{GS} = 10\text{ V}, I_D = 30\text{ A}$		4	5.6	$\text{m}\Omega$
		$V_{GS} = 4.5\text{ V}, I_D = 20\text{ A}$		7	10	$\text{m}\Omega$

Dynamic Characteristics

C_{ISS}	Input Capacitance	$V_{DS} = 15\text{ V}, V_{GS} = 0\text{ V},$ $F = 1\text{ MHz}$		1636		pF
C_{OSS}	Output Capacitance			194		pF
C_{RSS}	Reverse Transfer Capacitance			217.0		pF
R_G	Gate Resistance	$F = 1\text{ MHz}$		3.6		Ω

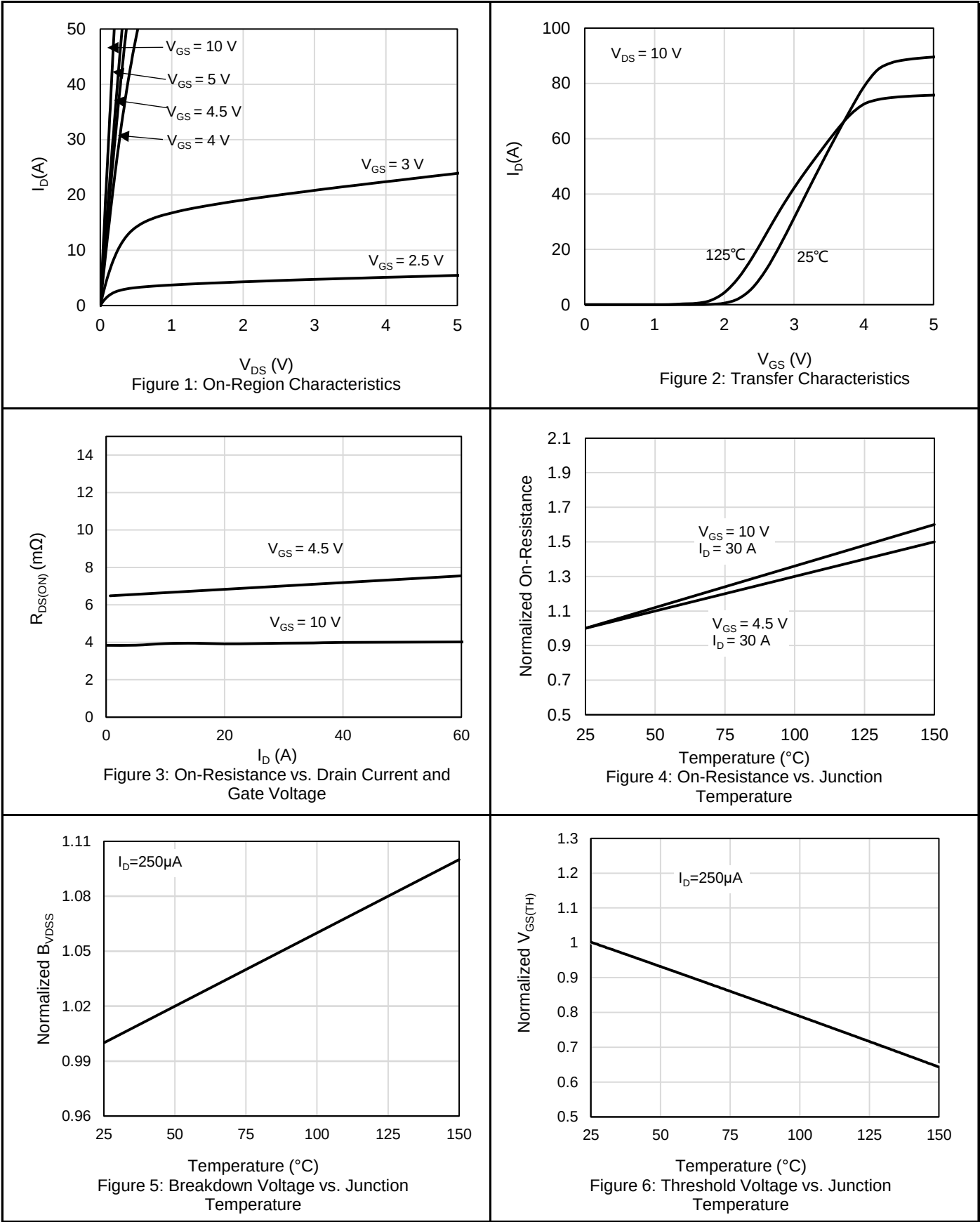
Switching Characteristics

$T_{D(ON)}$	Turn On Delay Time	$V_{DD} = 15\text{ V}, R_L = 0.5\text{ }\Omega,$ $V_{GS} = 10\text{ V}, R_G = 3\text{ }\Omega$		7.5		ns
T_R	Rise Time			50		ns
$T_{D(OFF)}$	Turn Off Delay Time			37.5		ns
T_F	Fall Time			93.5		ns
Q_G	Total Gate Charge	$V_{DD} = 15\text{ V}, I_D = 30\text{ A},$ $V_{GS} = 10\text{ V}$		34.5		nC
Q_{GS}	Gate-Source Charge			4.8		nC
Q_{GD}	Gate-Drain Charge			9.5		nC

Drain-Source Diode Characteristics and Maximum Ratings

I_S	Maximum Continuous Body-Diode Forward Current			70	A
I_{SM}	Maximum Pulsed Body-Diode Forward Current			280	A
V_{SD}	Diode Forward Voltage	$V_{GS} = 0\text{ V}, I_S = 30\text{ A}$		0.86	V
T_{RR}	Reverse recovery time	$V_{DD} = 15\text{ V}, I_D = 30\text{ A},$ $di/dt = 100\text{ A}/\mu\text{s}$		65	ns
Q_{RR}	Reverse recovery charge			78.0	nC
I_{RRM}	Peak Reverse Recovery Current			2.5	A

Electrical Characteristics Diagrams



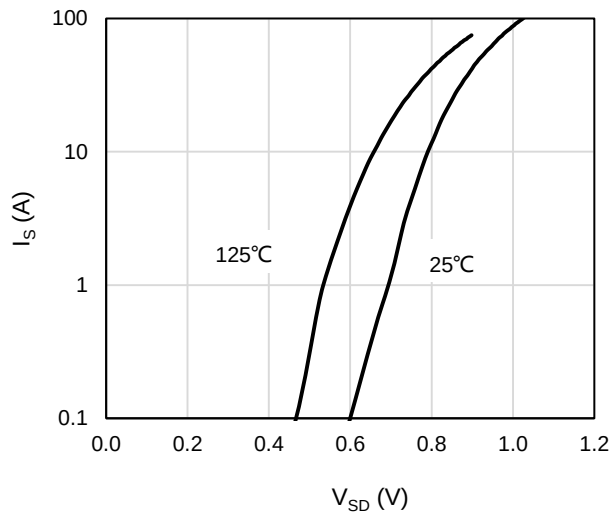


Figure 7: Body-Diode Characteristics

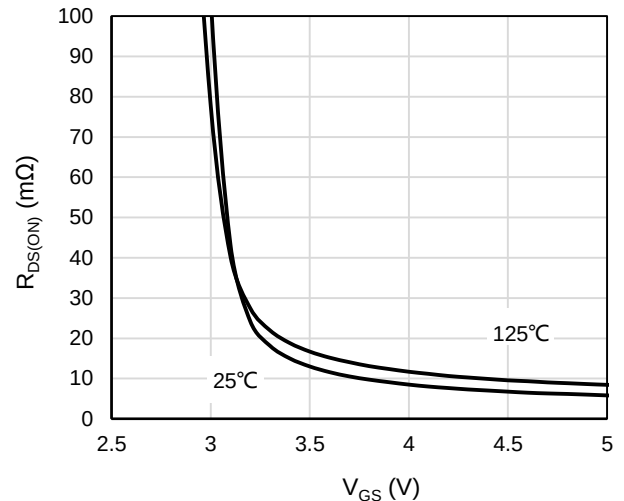


Figure 8: On-Resistance vs. Gate-Source Voltage

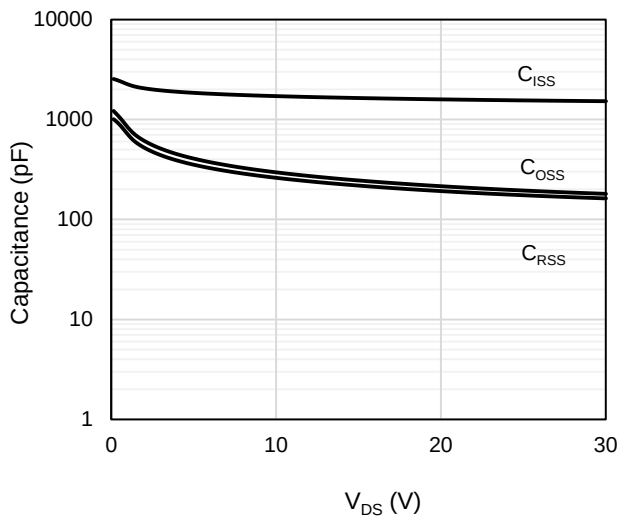


Figure 9: Capacitance Characteristics

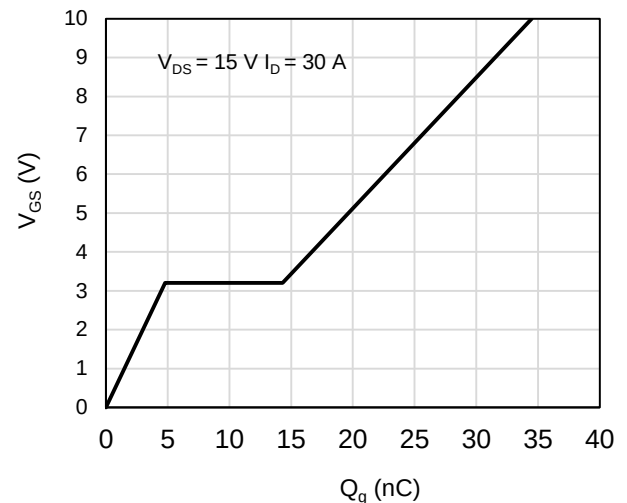


Figure 10: Gate-Charge Characteristics

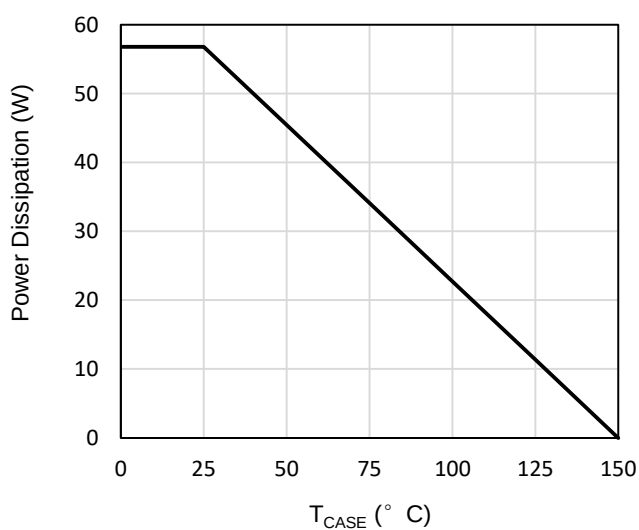


Figure 11: Power De-rating

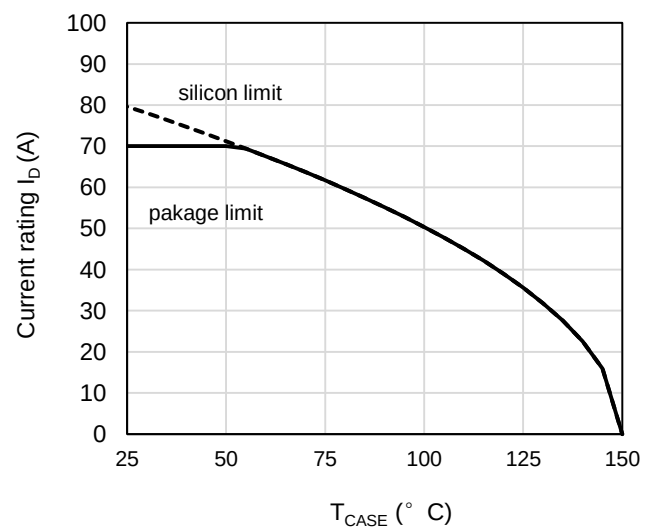


Figure 12: Current De-rating

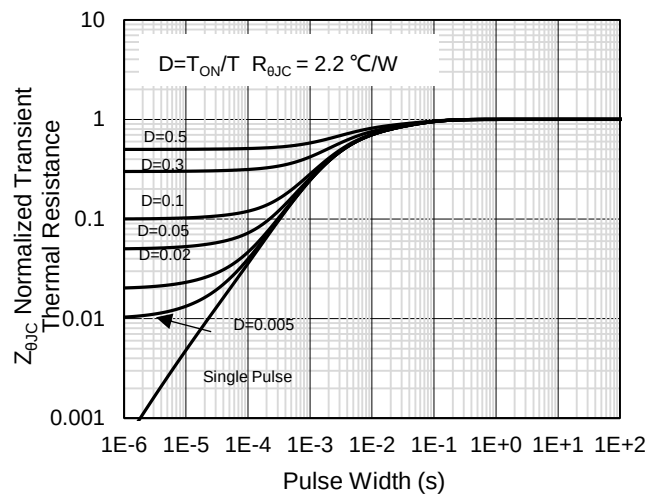


Figure 13: Normalized Maximum Transient Thermal Impedance

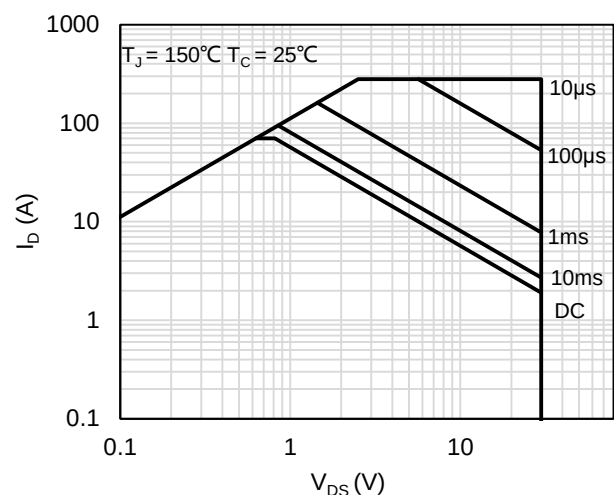
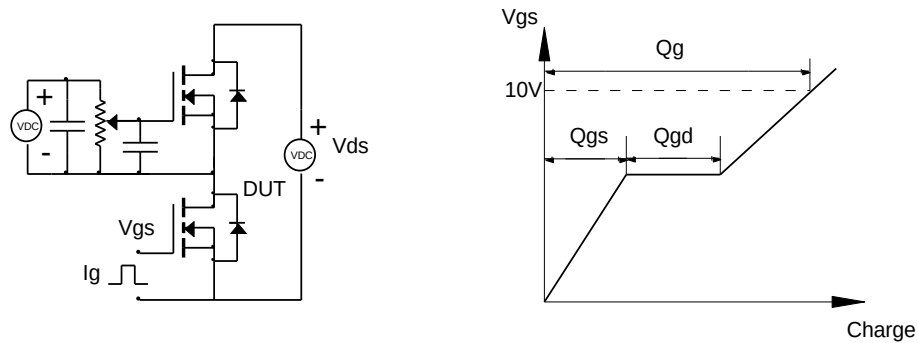


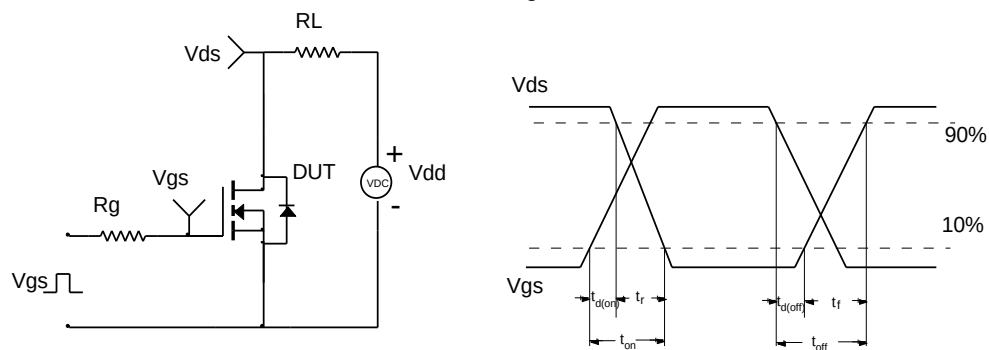
Figure 14: Maximum Forward Biased Safe Operating Area

Test Circuit and Waveform

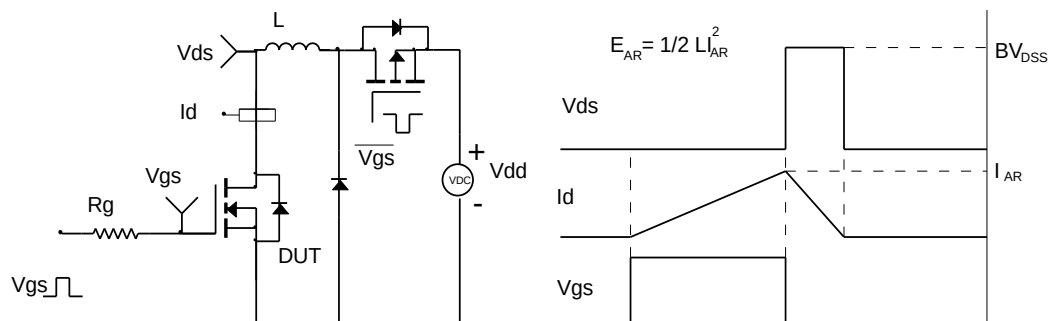
Gate Charge Test Circuit & Waveform



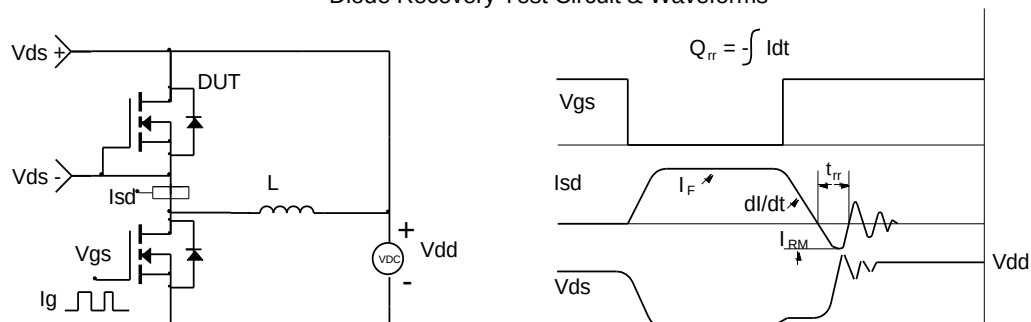
Resistive Switching Test Circuit & Waveforms



Unclamped Inductive Switching (UIS) Test Circuit & Waveforms



Diode Recovery Test Circuit & Waveforms



Revision History

Revision	Release Date	Remark
Rev.1.1	2025	

Disclaimer

The information given in this document describes the independent performance of the product, but similar performance is not guaranteed under other working conditions, and cannot be guaranteed when installed with other products or equipment. To achieve the required performance of the product in actual scenarios, the customer should conduct a complete application test to assess the functionality of the product.

Alkaidsemi assumes no responsibility for equipment failures result from using products at values that exceed the ratings, operating conditions, or other parameters listed in the product specifications.

The product described in this specification is not applicable for aerospace or other applications which requires high reliability. Customers using or selling these products for use in medical, life-saving, or life-sustaining applications do so at their own risk and agree to fully indemnify.

Due to product or technical improvements, the information described or contained herein may be changed without prior notice.